seard	 	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/784,979	YACH ET AL.
Examiner	Art Unit
Shew-Fen Lin	2166

		 	
SEARCHED			
Class	Subclass	Date	Examiner
<u> </u>			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	, ,		
L			

SEARCH NOT (INCLUDING SEARCH	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
EAST	3/1/2007	SFL	
·			